



Integrated Device Technology, Inc.
6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)

PCN #: TB1209-01R1 DATE: October 17, 2012 Product Affected: Various part#. Refer attachment II Date Effective: January 5, 2013	MEANS OF DISTINGUISHING CHANGED DEVICES: <input type="checkbox"/> Product Mark <input type="checkbox"/> Back Mark <input type="checkbox"/> Date Code <input checked="" type="checkbox"/> Other <p style="font-size: small;">Traceability to the test location is maintained by IDT and available on request</p>
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Contact: Mary Vesey Title: Director, Product Assurance Phone #: (408) 284-4565 Fax #: (408) 284-1450 E-mail: Mary.Vesey@idt.com	Attachment: <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No Samples: Please contact your local IDT sales representative for sample requests.
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DESCRIPTION AND PURPOSE OF CHANGE:

<input type="checkbox"/> Die Technology <input type="checkbox"/> Wafer Fabrication Process <input type="checkbox"/> Assembly Process <input type="checkbox"/> Equipment <input type="checkbox"/> Material <input checked="" type="checkbox"/> Testing - Test Site <input type="checkbox"/> Manufacturing Site <input type="checkbox"/> Data Sheet <input type="checkbox"/> Other	<p>Revision 1: This revised notification is to add several affected part#, which have been inadvertently left out in the original notice of change. PCN effective date remains unchanged. Refer to Attachment II for the added part# and the updated affected part# list.</p> <p>Original Notice: This notification is to advise our customers that IDT is adding UTAC, Thailand as an alternate facility for Test process for the selective products that are presently tested at IDT Penang, Malaysia facility.</p> <p style="text-align: center;">Attachment I details the change and Attachment II lists the affected part numbers.</p>
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RELIABILITY/QUALIFICATION SUMMARY:
There is no expected change to the product quality or reliability performance. Please refer to Attachment I for Electrical correlation data.

CUSTOMER ACKNOWLEDGMENT OF RECEIPT:
IDT records indicate that you require written notification of this change. Please use the acknowledgement below or E-Mail to grant approval or request additional information. If IDT does not receive acknowledgement within 30 days of this notice it will be assumed that this change is acceptable.
IDT reserves the right to ship either version manufactured after the process change effective date.

Customer: _____	<input type="checkbox"/> <i>Approval for shipments prior to effective date.</i>
Name/Date: _____	E-Mail Address: _____
Title: _____	Phone# /Fax# : _____

CUSTOMER COMMENTS: _____

IDT ACKNOWLEDGMENT OF RECEIPT:

RECD. BY: _____ DATE: _____



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ATTACHMENT I - PCN # : TB1209-01R1

PCN Type: Alternate Test Site

Data Sheet Change: No Change

Details Of Change:

This notification is to advise our customers that IDT is adding UTAC, Thailand as an alternate facility for Test process for the selective products that are presently tested at IDT Penang, Malaysia facility.

This change will allow IDT the flexibility to ship from either facility and will provide the increased capacity, flexibility and shorter lead time to meet market demand.

There is no change in the Test processing flows. Testers, load boards and test programs are the same at both qualified facilities. IDT has completed the electrical test correlation and based on the test results we do not anticipate any impact on device performance. The testing is fully compatible and transferrable between the test facilities with no change to the test coverage.

There is no change in the moisture sensitivity level (MSL).

If you require samples to conduct evaluations, please contact your local sales representative to acknowledge this PCN and request samples.



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ATTACHMENT I - PCN # : TB1209-01R1

Qualification Information and Qualification Data:

Electrical Test Correlation Results

Vehicle: 8535AGI-31 (PGG20)

Sample size: 1000 electrically good units and 306 reject units

Description	IDT Penang, Malaysia (Existing Facility)	UTAC, Thailand (Alternate Facility)
Tester Platform	NEXTEST PT	NEXTEST PT
Loadboard & Test Program	IDT Load board and Test Program	IDT Load board and Test Program
Test Site	Single site	Single site
Test Temperature	25°C	25°C
Test Correlation Results (Both Good and Rejects)	100%	100%
Number of Good Units Correlated @ 25°C	1000 pcs	1000 pcs
Number of Reject Units Correlated @ 25°C	306 pcs	306 pcs



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ATTACHMENT II - PCN # : TB1209-01R1

Affected Part# Added in Revision 1

IDT Part Number	IDT Part Number	IDT Part Number	IDT Part Number
8535AG-01HCLF	8535AGLFT-ACT	8535AG-31LF-HC	8535AGI-31LFT
8535AG-ACT	8535AG-31-ACT	8535AG-31LFT-ACT	
8535AGT-ACT	8535AG-31T-ACT	8535AG-31LFT-HC	
8535AGLF-ACT	8535AG-31LF-ACT	8535AGI-31LF	

Updated Affected Part Number List

IDT Part Number	IDT Part Number	IDT Part Number	IDT Part Number
8535AG-01	8535AG-31LF	8535AG-31T-ACT	8535AGI-31LF
8535AG-01HCLF	8535AG-31LF-ACT	8535AG-ACT	8535AGI-31LFT
8535AG-01LF	8535AG-31LF-HC	8535AGI-01	8535AGI-31T
8535AG-01LFT	8535AG-31LFT	8535AGI-01LF	8535AGLF-ACT
8535AG-01T	8535AG-31LFT-ACT	8535AGI-01LFT	8535AGLFT-ACT
8535AG-31	8535AG-31LFT-HC	8535AGI-01T	8535AGT-ACT
8535AG-31-ACT	8535AG-31T	8535AGI-31	